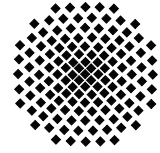


Stuttgarter Physikalisches Kolloquium

Max-Planck-Institut für Festkörperforschung
Max-Planck-Institut für Intelligente Systeme
Fachbereich Physik, Universität Stuttgart

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17.15 Uhr

Hörsaal 2 D5

Stuttgarter Max-Planck-Institute, Heisenbergstraße 1, 70569 Stuttgart-Büsnau

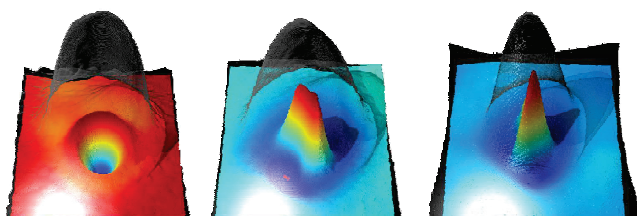
Breaking resolution barriers with atomic force microscopy

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Abstract

Atomic force microscopy (AFM) and scanning tunneling microscopy (STM) provide a direct access to the world of single atoms, allowing to image surfaces with atomic resolution, to perform local spectroscopy of current versus voltage, forces and dissipation. The qPlus force sensor [1] is a sensitive eye and hand to the nanoworld by combining STM and AFM capability, enabling highly precise imaging and spectroscopy functions and measuring the forces that act during atomic manipulation [2]. The figure below [3] shows an example, where combined AFM/STM reveals two strongly distinct aspects of the atomic structure of matter. The gray veil depicts the inverted tunneling current between a CO molecule adsorbed on Cu(111) and a tungsten tip, while the colored surface shows the corresponding force profiles, where the force profiles show a vastly increased spatial resolution over the tunneling current [3]. Strong angular dependencies of chemical bonding forces have been observed before for Si tips interacting with Si surfaces [4], W tips interacting with graphite [5] and similarities exist between metal tips interacting with CO molecules on Cu and Si adatoms [6]. In the latter two cases, light atoms such as carbon or oxygen interacted with much heavier and much larger metal atoms. Recently, Gross et al. found that CO is an excellent probe for organic molecules. For example, pentacene can be imaged at excellent resolution with CO terminated tips [7], although the softness of CO on tips can lead to image distortions [8,9]. Tips made of permanent magnets such as CoSm allow to resolve the spin order in the antiferromagnetic insulator nickel oxide [10]. The stiff cantilever/small amplitude technique used here also allows true atomic resolution in ambient conditions [11].



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